


<b>Search Notes</b>  	<b>Application/Control No.</b>  10505452	<b>Applicant(s)/Patent Under Reexamination</b>  OHNO ET AL.
	<b>Examiner</b>  Waghray, Anu	<b>Art Unit</b>  1609

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
PubMed	01/16/07	AW
STN	01/29/07	AW
STN	01/30/07	AW
WEST	01/25/07	AW
EAST	01/30/07	AW
PALM, Applicant Name	01/31/07	AW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner